

Search Notes

Application/Control No.

10/001,756

Examiner

John S. Chu

Applicant(s)/Patent under Reexamination

BECK

Art Unit

1752

SEARCHED

Class	Subclass	Date	Examiner
430	270.1	9/2006	JSC
548	440		
549	43		
549	48		
438	99		
257	40		

INTERFERENCE SEARCHED

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430	270.1	9/2006	JSC
548	440		
549	43,48		
438/99			

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
UPDATED	9/2006	JSC

Search Notes (continued)	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/001,756	BECK
Examiner	Art Unit	
John S. Chu	1752	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
516	203	9/26/66	JSC
516	204	1	L